

SMARIEC Z Line-Loop / RCDMI 3122 Instruction manual

Version 1.2, Code no. 20 751 245



Distributor:

Manufacturer:

METREL d.d. Ljubljanska cesta 77 1354 Horjul Slovenia

web site: http://www.metrel.si e-mail: metrel@metrel.si



Mark on your equipment certifies that this equipment meets the requirements of the EU (European Union) concerning safety and electromagnetic compatibility regulations

© 2008 METREL

The trade names Metrel, Smartec, Eurotest, Autosequence are trademarks registered or pending in Europe and other countries.

No part of this publication may be reproduced or utilized in any form or by any means without permission in writing from METREL.

1	Pref	ace	5
2	Safe	ety and operational considerations	6
		Warnings and notes	
	2.2	Battery and charging	
	2.2.		
	2.3	Standards applied	10
3	Inst	rument description	11
	3.1	Front panel	11
	3.2	Connector panel	
	3.3	Back site	13
	3.4	Display organization	
	<i>3.4.</i>	1 Terminal voltage monitor	14
	3.4.	2 Battery indication	14
	3.4.		
	3.4.		_
	3.4.	3	
	<i>3.4.</i>	- -	
	3.4.	5 · · · · · · · · · · · · · · · · · · ·	
	3.5	Instrument set and accessories	
	3.5.		
	3.5.		
4	Inst	rument operation	18
	4.1	Function selection	
	4.2	Settings	
	4.2.	- J - J -	
	4.2.	3 · · · · · · · · · · · · · · · · · · ·	
	4.2.		21
	4.2.		
	4.2.		
	4.2.		
	4.2.		
5	Mea	surements	24
	5.1	Testing RCDs	24
	5.1.	3 (3)	
	5.1.	1	
	5.1.	, ,	
	5.1.		
	5.2	Fault loop impedance and prospective fault current	
	5.3	Line impedance and prospective short-circuit current	
	5.4	Voltage, frequency and phase sequence	
_	5.5	PE test terminal	
6		a handling	
	6.1	Memory organization	
	6.2	Data structure	
	6.3	Storing test results	
	6.4	Recalling test results	
	6.5	Clearing stored data	42

	6.5.	1 Clearing complete memory content	42
	6.5.2		
	6.5.3	3 Clearing individual measurements	43
	6.6	Communication	44
7	Mair	ntenance	45
	7.1	Cleaning	45
		Periodic calibration	
		Service	
8	Tech	hnical specifications	46
	8.1	RCD testing	46
	8.1.1	-	
	8.1.2	2 Contact voltage RCD-Uc	46
	8.1.3	<u> </u>	
	8.1.4		
	8.2	Fault loop impedance and prospective fault current	47
	8.2.		
	8.2.2		
	8.3	Line impedance and prospective short-circuit current	48
	8.4	Voltage, frequency, and phase rotation	49
	8. <i>4</i> .		
	8.4.2	2 Voltage	49
	8.4.3	3 Frequency	49
	8.5	Online terminal voltage monitor	49
		General data	
A	A	ppendix A - Fuse table	51
	A.1	Fuse table - IPSC	51
		Fuse table - impedances (UK)	
В	Αı	ppendix B - Accessories for specific measurements	55

1 Preface

Congratulations on your purchase of the instrument and its accessories from METREL. The instrument was designed on basis of rich experience, acquired through many years of dealing with electric installation test equipment.

The multifunctional hand-held installation tester Smartec Z Line-Loop / RCD is intended for tests and measurements required for inspection of electrical installations in buildings. In general for the following tests and measurements:

- □ True rms voltage, frequency, and phase sequence,
- □ Line impedance,
- Loop impedance,
- RCD protection,

The graphic display with backlight offers easy reading of results, indications, measurement parameters and messages. Two LED Pass/Fail indicators are placed at the sides of the LCD.

The operation of the unit is clear and simple – the operator does not need any special training (except reading this instruction manual) to operate the instrument.

In order for operator to be familiar enough with performing measurements in general and their typical applications it is advisable to read Metrel handbook *Guide for testing and verification of low voltage installations*.

The instrument is equipped with all the necessary accessory for comfortable testing.

2 Safety and operational considerations

2.1 Warnings and notes

In order to reach high level of operator's safety while carrying out various tests and measurements using Smartec Z Line-Loop / RCD, as well as to keep the equipment undamaged, it is necessary to consider the following general warnings:

- □ If the test equipment is used in a manner not specified in this user manual the protection provided by the equipment might be impaired!
- □ Read this user manual carefully, otherwise use of the instrument may be dangerous for the operator, for the instrument or for the equipment under test!
- Do not use the instrument and accessories if any damage is noticed!
- Consider all generally known precautions in order to avoid risk of electric shock while dealing with hazardous voltages!
- Do not use the instrument in supply systems with voltages higher than 600 V!
- Service intervention or adjustment and calibration procedure is allowed to be carried out only by a competent authorized person!
- Use only standard or optional test accessories supplied by your distributor!
- Consider that older and some of new optional test accessories compatible with this instrument meet overvoltage category CAT III / 300 V! It means that maximum allowed voltage between test terminals and ground is 300 V!
- Instrument contains rechargeable NiCd or NiMh battery cells. The cells should only be replaced with the same type as defined on the battery placement label or in this manual. Do not use standard alkaline battery cells while power supply adapter is connected, otherwise they may explode!
- Hazardous voltages exist inside the instrument. Disconnect all test leads, remove the power supply cable and switch off the instrument before removing battery compartment cover.
- All normal safety precautions have to be taken in order to avoid risk of electric shock when working on electrical installations!

Notes related to measurement functions:

General

- □ Indicator ★ means that the selected measurement can't be performed because of irregular conditions on input terminals.
- □ PASS / FAIL indication is enabled when parameters are set. Apply appropriate limit value for evaluation of measurement results.
- □ In case that only two of three wires are connected to test electrical installation, only voltage indication between these two wires is valid.

RCD functions

- Parameters set in one function are also kept for other RCD functions.
- □ The Contact voltage test will normally not trip-out RCD of tested installation. However, the RCD trip-out may occur and Uc measurement is affected as a result of existing PE leakage currents in the installation.
- □ RCD trip-out current and time will be measured only if the contact voltage pretest passed successfully.
- □ L and N test terminals are reversed automatically according to detected terminal voltage (except in UK version).
- \square It can happen that the RCD trips-out during the safety pretests. Possible reasons for trip-out are incorrect set RCD parameters ($I_{\Delta N}$), existing leakage currents or defective RCD.

Z-LOOP

- □ The Z-LOOP impedance function will trip-out the RCD in RCD protected installation that is tested. Use the Zs rcd impedance function to prevent the trip-out.
- □ The Zs rcd impedance function takes longer time to complete but has much better accuracy then R_L sub-result in RCD: Uc function.
- Specified accuracy of tested parameters is valid only if mains voltage is stable during the measurement.
- □ L and N test terminals are reversed automatically according to detected terminal voltage (except in UK version).

Z-LINE

- \Box In case of measurement of $Z_{\text{Line-Line}}$ with the instrument test leads PE and N connected together the instrument will display a warning of dangerous PE voltage. The measurement will be performed anyway.
- Specified accuracy of tested parameters is valid only if mains voltage is stable during the measurement.
- □ L and N test terminals are reversed automatically according to detected terminal voltage (except in UK version).

2.2 Battery and charging

The instrument uses six AA size alkaline or rechargeable Ni-Cd or Ni-MH battery cells. Nominal operating time is declared for cells with nominal capacity of 2100 mAh.

Battery condition is always displayed in the lower right display part.

In case the battery is too weak the instrument indicates this as shown in figure 2.1. This indication appears for a few seconds and then the instrument turns itself off.

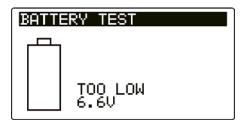


Figure 2.1: Discharged battery indication

The battery is charged whenever the power supply adapter is connected to the instrument. Internal circuit controls charging assuring maximum battery lifetime. The power supply socket polarity is shown in figure 2.2.



Figure 2.2: Power supply socket polarity

The instrument automatically recognizes the connected power supply adapter and begins charging.



Figure 2.3: Charging indication

- □ ⚠ Before opening battery compartment cover disconnect all measuring accessories connected to the instrument and switch off the instrument.
- □ Insert cells correctly, otherwise the instrument will not operate and the batteries could be damaged.
- □ Remove all battery cells from the battery compartment if the instrument is not used for a long period of time.
- Do not charge alkaline battery cells!
- □ Take into account handling, maintenance and recycling requirements that are defined by related regulations and manufacturers of alkaline or rechargeable batteries!
- □ Use only power supply adapter delivered from the manufacturer or distributor of the test equipment to avoid possible fire or electric shock!

2.2.1 New battery cells or cells unused for a longer period

Unpredictable chemical processes can occur during charging of new battery cells or cells that were unused for a longer period (more than 3 months). Ni-MH and Ni-Cd battery cells are affected to capacity degradation (sometimes called as memory effect). As a result the instrument operation time can be significantly reduced.

Recommended procedure for recovering battery cells:

Procedure		Notes
>	Completely charge the battery.	At least 14h with in-built charger.
>	Completely discharge the battery.	Use the instrument for normal testing until the unit displays the "Bat" symbol on screen.
>	Repeat the charge / discharge cycle for at least twice .	Four cycles are recommended.

Complete discharge / charge cycle can be performed automatically for each cell using external intelligent battery charger.

Notes:

- □ The charger in the instrument is a pack cell charger. This means that the battery cells are connected in series during the charging. The battery cells have to be equivalent (same charge condition, same type and age).
- One different battery cell can cause an improper charging and incorrect discharging during normal usage of the entire battery pack (it results in heating of the battery pack, significantly decreased operation time, reversed polarity of defective cell,...).
- If no improvement is achieved after several charge / discharge cycles, then each battery cell should be checked (by comparing battery voltages, testing them in a cell charger, etc). It is very likely that only some of the battery cells are deteriorated.
- The effects described above should not be confused with the normal decrease of battery capacity over time. Battery also loses some capacity when it is repeatedly charged / discharged. Actual decreasing of capacity, versus number of charging cycles, depends on battery type. This information is provided in the technical specification from battery manufacturer.

2.3 Standards applied

The MI 3122 Smartec Z Line-Loop / RCD instrument is manufactured and tested according to the following regulations, listed below.

Electromagnetic	compatibility ((EMC)

IEC/ EN 61326-1	Electrical equipment for measurement, control and laboratory use - EMC requirements Part 1: General requirements
IEC/EN 61326-2-2	Class B (Hand held equipment used in controlled EM environments) Electrical equipment for measurement, control and laboratory use - EMC requirements Part 2-2: Particular requirements - Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low- voltage distribution systems
Safety (LVD)	
IEC/ EN 61010 - 1	Safety requirements for electrical equipment for measurement, control, and laboratory use – Part 1: General requirements
IEC/ EN 61010 - 03	
Functionality	
1	lectrical safety in low voltage distribution systems up to 1000 V a.c. and 500 V d.c Equipment for testing, measuring or monitoring of rotective measures

General requirements

Loop resistance

Phase sequence

Other reference standards for testing RCDs

Part 10

Part 1

Part 3

Part 6 Part 7

IEO/ EN 04000	Residual current operated circuit-breakers without integral
IEC/ EN 61008	overcurrent protection for household and similar uses
IEC/ EN 61009	Residual current operated circuit-breakers with integral overcurrent protection for household and similar uses
	General requirements for residual current operated protective
IEC/ EN 60755	devices
	Electrical installations of buildings - Part 4-41: Protection for safety
IEC/ EN 60364-4-41	- Protection against electric shock
BS 7671	IEE Wiring Regulations
AS / NZ 3760	In-service safety inspection and testing of electrical equipment

Combined measuring equipment

Residual current devices (RCDs) in TT and TN systems

3 Instrument description

3.1 Front panel



Figure 3.1: Front panel

Legend:

	LCD TEST	128 x 64 dots matrix display with backlight. TEST Starts measurements. Acts also as the PE touching electrode.	
3	UP	Modifies selected parameter.	
4	DOWN		
5	MEM	Store / recall / clear tests in memory of instrument.	
6	Function selectors	Selects test function.	
7	Backlight, Contrast	Changes backlight level and contrast.	
8	ON / OFF	Switches the instrument power on or off. The instrument automatically turns off 15 minutes after the last key was pressed.	
9	HELP / DISPLAY	Accesses help menus. In RCD Auto toggles between top and bottom parts of results field.	
10	TAB	Selects the parameters in selected function.	
11 12	PASS FAIL	Indicate acceptance of result.	

3.2 Connector panel

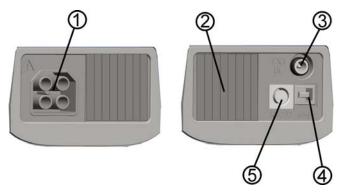


Figure 3.2: Connector panel

Legend:

1	Test connector	Measuring inputs / outputs, connection of measuring cables.	
2 Protection cover Protects from simultaneous access to test connector and supply adapter socket / communication connectors.			
3	Charger socket	Connection of power supply adapter.	
4	USB connector	Communication with PC USB (1.1) port.	
5	PS/2 connector	Communication with PC serial port and connection to optional measuring adapters.	

Warnings!

- □ Maximum allowed voltage between any test terminal and ground is 600 V!
- □ Maximum allowed voltage between test terminals is 600 V!
- □ Maximum short-term voltage of external power supply adapter is 14 V!

3.3 Back site

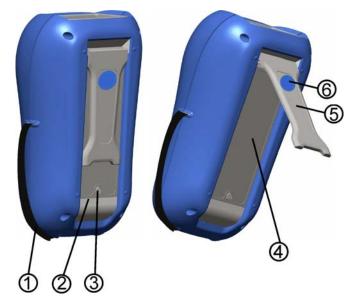


Figure 3.3: Back site

Legend:

Side belt
Battery compartment cover
Fixing screw for battery compartment cover
Back panel information label
Holder for inclined position of the instrument
Magnet for fixing instrument close to tested item (optional)

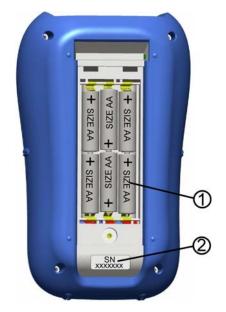


Figure 3.4: Battery compartment

Legend:

1	Battery cells	Size AA, alkaline or rechargeable NiMH / NiCd
2	Serial number label	

3.4 Display organization

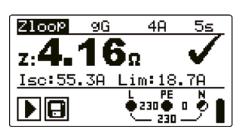
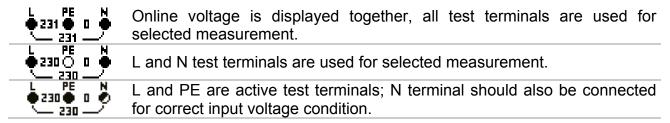


Figure 3.5: Typical function display

Zloop	Function name
z: 4.16 Ω ✓	Result field
9G 4A 5s	Test parameter field
	Message field
L PE N ⊕ 230 ⊕ 0 ♥	Terminal voltage monitor
1	Battery indication

3.4.1 Terminal voltage monitor

The terminal voltage monitor displays on-line the voltages on the test terminals and information about active test terminals.



3.4.2 Battery indication

The indication indicates the charge condition of battery and connection of external charger

	Battery capacity indication.
	Low battery. Battery is too weak to guarantee correct result. Replace or recharge the battery cells.
Ď	Recharging in progress (if power supply adapter is connected).

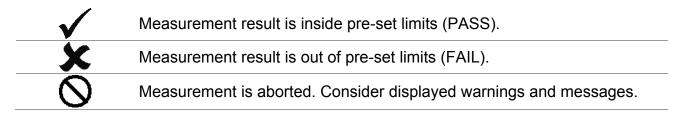
3.4.3 Message field

In the message field warnings and messages are displayed.

\mathbb{X}	Measurement is running, consider displayed warnings.
▶	Conditions on the input terminals allow starting the measurement; consider other displayed warnings and messages.
\mathbf{x}	Conditions on the input terminals do not allow starting the measurement, consider displayed warnings and messages.
₽ _₽	RCD tripped-out during the measurement (in RCD functions).

	Instrument is overheated. The measurement is prohibited until the temperature decreases under the allowed limit.
	Result(s) can be stored.
-\-	High electrical noise was detected during measurement. Results may be impaired.
Ф	L – N polarity are changed.
4	Warning! Dangerous voltage on the PE terminal! Stop the activity immediately and eliminate the fault / connection problem before proceeding with any activity!

3.4.4 Result field



3.4.5 Sound warnings

Continuous sound Warning! Dangerous voltage on the PE terminal is detected.

3.4.6 Help screens

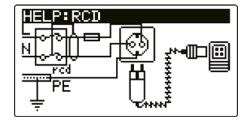
HELP	Opens help screen.	
------	--------------------	--

The help menus contain some basic schematic / connection diagrams to illustrate recommended connection of the instrument to the electrical installation and information about the instrument.

Pressing the **HELP** key in main function menu generates help screen for selected function.

Keys in help menu:

UP / DOWN	Selects next / previous help screen.
HELP	Scrolls through help screens.
Function selectors / TEST	Exits help menu.



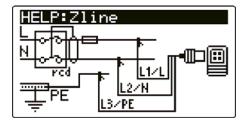


Figure 3.6: Examples of help screens

Note:

□ Function of the key **Help** is modified to DISPLAY in RCD-Auto.

3.4.7 Backlight and contrast adjustments

With the **BACKLIGHT** key backlight and contrast can be adjusted.

Click	Toggles backlight intensity level.	
Keep pressed for 1 s	Locks high intensity backlight level until power is turned off or the key is pressed again.	
Keep pressed for 2 s	Bargraph for LCD contrast adjustment is displayed.	

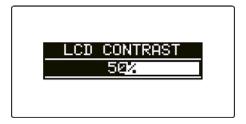


Figure 3.7: Contrast adjustment menu

Keys for contrast adjustment:

DOWN	Reduces contrast.
UP	Increases contrast.
TEST	Accepts new contrast.
Function selectors	Exits without changes.

3.5 Instrument set and accessories

3.5.1 Standard set

- Instrument
- Short instruction manual
- Product verification data
- Warranty declaration
- Declaration of conformity
- Mains measuring cable
- Universal test cable
- Three test tips

- □ Three alligator clips
- □ Set of NiMH battery cells
- Power supply adapter
- CD with instruction manual, and "Guide for testing and verification of low voltage installations" handbook
- Soft hand strap

3.5.2 Optional accessories

See the attached sheet for a list of optional accessories that are available on request from your distributor.

4 Instrument operation

4.1 Function selection

For selecting test function the **FUNCTION SELECTOR** shall be used.

Keys:

	Select test / measurement function:	
FUNCTION SELECTOR	 <voltage trms=""> Voltage and frequency and phase sequence.</voltage> <z-line> Line impedance.</z-line> <z-loop> Fault loop impedance.</z-loop> <rcd> RCD testing.</rcd> <settings> General settings.</settings> 	
UP/DOWN	Selects sub-function in selected measurement function.	
TAB	Selects the test parameter to be set or modified.	
TEST	Runs selected test / measurement function.	
MEM	Stores measured results / recalls stored results.	

Keys in **test parameter** field:

UP/DOWN Changes the selected parameter.	
TAB Selects the next measuring parameter.	
FUNCTION SELECTOR	Toggles between the main functions.
MEM	Stores measured results / recalls stored results.

General rule regarding enabling **parameters** for evaluation of measurement / test result:

	OFF	No limit values.								
Parameter o	ON	Value(s) - results				as	PASS	or	FAIL	in
		accordance with selected limit.								

See Chapter 5 for more information about the operation of the instrument test functions.

4.2 Settings

Different instrument options can be set in the **SETTINGS** menu.

SETTINGS 29:33 SELECT LANGUAGE INITIAL SETTINGS MEMORY SET DATE/TIME PROD testing

Options are:

- Selection of language,
- Setting the instrument to initial values,
- Recalling and clearing stored results,
- Setting the date and time,
- Selection of reference standard for RCD test,
- Entering Isc factor,
- Support of commanders.





UK version

Figure 4.1: Options in Settings menu

Keys:

UP / DOWN	Selects appropriate option.	
TEST	Enters selected option.	
Function selectors	Exits back to main function menu.	

4.2.1 Language

The instrument supports different languages.

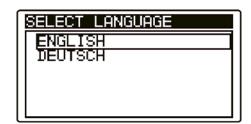


Figure 4.2: Language selection

Keys:

UP / DOWN	Selects language.
TEST	Confirms selected language and exits to settings menu.
Function selectors	Exits back to main function menu.

4.2.2 Initial settings

Selecting this option will allow the user to reset the instrument settings and measurement parameters and limits to the manufacturers standard values.



Figure 4.3: Initial settings dialogue

Keys:

TEST	Restores default settings.	
Function selectors	Exits back to main function menu without changes.	

Warning:

- Custom made settings will be lost when this option is used!
- □ If the batteries are removed for more than 1 minute the custom made settings will be lost.

The default setup is listed below:

Instrument setting	Default value
Contrast	As defined and stored by adjustment procedure
Isc factor (except in UK version)	1.00
Z factor (UK version only)	0.8
RCD standards	EN 61008 / EN 61009
Language	English

Function Sub-function	Parameters / limit value
Z - LINE	Fuse type: none selected
Z - LOOP	Fuse type: none selected
Zs rcd	Fuse type: none selected
RCD	RCD t
	Nominal differential current: I _{ΔN} =30 mA
	RCD type: G
	Test current starting polarity: △ (0°)
	Limit contact voltage: 50 V
	Current multiplier: ×1

Note:

Initial settings (reset of the instrument) can be recalled also if the TAB key is pressed while the instrument is switched on.

4.2.3 Memory

In this menu the stored data can be recalled and deleted. See chapter 6 Data handling for more information.

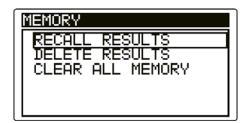


Figure 4.4: Memory options

Keys:

UP / DOWN	Selects option.	
TEST	Enters selected option.	
Function selectors	Exits back to main function menu.	

4.2.4 Date and time

Selecting this option will allow the user to set the date and time of the unit.



Figure 4.5: Setting date and time

Keys:

TAB	Selects the field to be changed.	
UP / DOWN	Modifies selected field.	
TEST	Confirms new setup and exits.	
Function selectors	Exits back to main function menu.	

Warning:

□ If the batteries are removed for more than 1 minute the set time and date will be lost.

4.2.5 RCD standard

RCD normative reference can be selected by this option.



Figure 4.6: Selection of RCD test standard

Keys:

UP / DOWN	Selects standard.	
TEST	Confirms selected standard.	
Function selectors	Exits back to main function menu.	

Maximum RCD disconnection times differ in various standards. The trip-out times defined in individual standards are listed below.

Trip-out times according to EN 61008 / EN 61009:

	½×Ι _{ΔΝ} *)	I_{\DeltaN}	2×I _{∆N}	5×I _{ΔN}
General RCDs (non-delayed)	t _∆ > 300 ms	t_{Δ} < 300 ms	$t_{\scriptscriptstyle \Delta}$ < 150 ms	t _△ < 40 ms
Selective RCDs (time-delayed)	t _△ > 500 ms	130 ms < t_{Δ} < 500 ms	60 ms < t _Δ < 200 ms	50 ms < t _Δ < 150 ms

Trip-out times according to EN 60364-4-41:

	½×I _{△N} *)	I_{\DeltaN}	2×I _{∆N}	5×I _{ΔN}
General RCDs (non-delayed)	t _∆ > 999 ms	t _∆ < 999 ms	t_{Δ} < 150 ms	t _△ < 40 ms
Selective RCDs (time-delayed)	t _∆ > 999 ms	130 ms < t _△ < 999 ms	$60 \text{ ms} < t_{\Delta} < 200 \text{ ms}$	50 ms < t _Δ < 150 ms

Trip-out times according to BS 7671:

	½×I _{∆N} *)	I_{\DeltaN}	$2 \times I_{\Delta N}$	$5 \times I_{\Delta N}$
General RCDs (non-delayed)	t _∆ > 1999 ms	t_{Δ} < 300 ms	$t_{\scriptscriptstyle \Delta}$ < 150 ms	t _△ < 40 ms
Selective RCDs (time-delayed)	t _∆ > 1999 ms	130 ms < t_{Δ} < 500 ms	$60 \text{ ms} < t_{\Delta} < 200 \text{ ms}$	$50 \text{ ms} < t_{\Delta} < 150 \text{ ms}$

Trip-out times according to AS/NZ**):

		$\frac{1}{2} \times _{\Delta N}^{*}$	I_{\DeltaN}	2×I _{∆N}	$5 \times I_{\Delta N}$		
RCD type	I _{∆N} [mA]	$t_{\scriptscriptstyle\Delta}$	$t_{\!\scriptscriptstyle\Delta}$	$t_{\scriptscriptstyle\Delta}$	$t_{\!\scriptscriptstyle\Delta}$	Note	
I	≤ 10		40 ms	40 ms	40 ms		
II	> 10 ≤ 30	> 999 ms	300 ms	150 ms	40 ms	Maximum break time	
III	> 30		300 ms	150 ms	40 ms		
IV S	> 30	> 999 ms	500 ms	200 ms	150 ms		
10 2	<i>-</i> 30	/ 999 IIIS	130 ms	60 ms	50 ms	Minimum non-actuating time	

^{*)} Minimum test period for current of ½×I_{ΔN}, RCD shall not trip-out.

Maximum test times related to selected test current for general (non-delayed) RCD

Standard	1⁄2×I _{∆N}	$I_{\Delta N}$	2×I _{∆N}	5×Ι _{ΔΝ}
EN 61008 / EN 61009	300 ms	300 ms	150 ms	40 ms
EN 60364-4-41	1000 ms	1000 ms	150 ms	40 ms
BS 7671	2000 ms	300 ms	150 ms	40 ms
AS/NZ (I, II, III)	1000 ms	1000 ms	150 ms	40 ms

Maximum test times related to selected test current for selective (time-delayed) RCD

Standard	1⁄2×I _{∆N}	$I_{\Delta N}$	2×I _{∆N}	5×Ι _{ΔΝ}
EN 61008 / EN 61009	500 ms	500 ms	200 ms	150 ms
EN 60364-4-41	1000 ms	1000 ms	200 ms	150 ms
BS 7671	2000 ms	500 ms	200 ms	150 ms
AS/NZ (IV)	1000 ms	1000 ms	200 ms	150 ms

^{**)} Test current and measurement accuracy correspond to AS/NZ requirements.

4.2.6 Isc factor

Isc factor for calculation of short circuit current in Z-LINE and Z-LOOP can be selected in this menu.

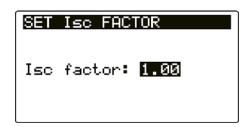


Figure 4.7: Selection of Isc factor

Keys:

UP / DOWN	Sets Isc value.
TEST	Confirms Isc value.
Function selectors	Exits back to main function menu.

Short circuit current lsc in the supply system is important for selection or verification of protective circuit breakers (fuses, over-current breaking devices, RCDs).

The default value of lsc factor (ksc) is 1.00. The value should be set according to local regulative.

Range for adjustment of the lsc factor is $0.20 \div 3.00$.

Notes:

- □ If not defined by other regulations, the recommended value for lsc factor is 0.75÷ 0.80. This value helps to consider the maximum working temperature for the installation and heating of the wires during a fault.
- □ In UK version, impedance scaling factor Z is used instead of prospective short/fault scaling factor Isc.

4.2.7 Commander

Selecting this option, the support for remote commanders can be switched On/ Off in this menu.



Figure 4.8: Selection of commander support

Keys:

UP / DOWN	Selects commander option.	
TEST	Confirms selected option.	
Function selectors	Exits back to main function menu.	

Note:

This option is intended to disable the commander's remote keys. In case of high EM interfering noise the operation of the commander's key can be irregular.

5 Measurements

5.1 Testing RCDs

Various test and measurements are required for verification of RCD(s) in RCD protected installations. Measurements are based on the EN 61557-6 standard.

The following measurements and tests (sub-functions) can be performed:

- Contact voltage,
- □ Trip-out time,
- Trip-out current,
- RCD autotest.

See chapter 4.1 Function selection for instructions on key functionality.

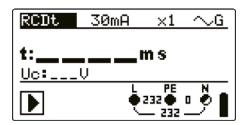


Figure 5.1: RCD test

Test parameters for RCD test and measurement

TEST	RCD sub-function test [RCDt, RCD I, AUTO, Uc].
$I_{\Delta N}$	Rated RCD residual current sensitivity $I_{\Delta N}$ [10 mA, 30 mA, 100 mA, 300 mA,
	500 mA, 1000 mA].
type	RCD type [G , S], test current waveform plus starting polarity $[\sim, \sim, \sim, \sim]$.
MUL	Multiplication factor for test current [$\frac{1}{2}$, 1, 2, 5 $I_{\Delta N}$].
Ulim	Conventional touch voltage limit [25 V, 50 V].

Notes:

Ulim can be selected in the Uc sub-function only.

The instrument is intended for testing of **G**eneral (non-delayed) and **S**elective (time-delayed) RCDs, which are suited for:

- □ Alternating residual current (AC type, marked with △ symbol),
- □ Pulsating residual current (A type, marked with ^- symbol).
- □ Time delayed RCDs have delayed response characteristics. As the contact voltage pre-test or other RCD tests influence the time delayed RCD it takes a certain period to recover into normal state. Therefore a time delay of 30 s is inserted before performing trip-out test by default.

Connections for testing RCD

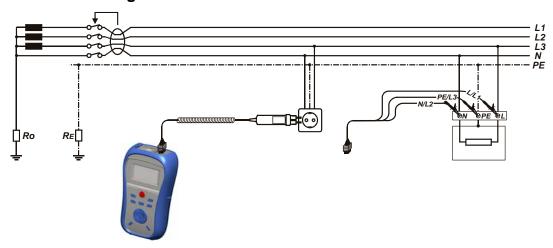


Figure 5.2: Connecting the plug commander and the universal test cable

5.1.1 Contact voltage (RCD Uc)

A current flowing into the PE terminal causes a voltage drop on earth resistance, i.e. voltage difference between PE equipotential bonding circuit and earth. This voltage difference is called contact voltage and is present on all accessible conductive parts connected to the PE. It shall always be lower than the conventional safety limit voltage. The contact voltage is measured with a test current lower than $\frac{1}{2}I_{\Delta N}$ to avoid trip-out of the RCD and then normalized to the rated $I_{\Delta N}$.

Contact voltage measurement procedure

- Select the RCD function using the function selector switch.
- Set sub-function Uc.
- Set test parameters (if necessary).
- □ **Connect** test cable to the top of the instrument.
- □ **Connect** test leads to the item to be tested (see *figure 5.2*).
- Press the **TEST** key to perform the measurement.
- □ **Store** the result by pressing the MEM key (optional).

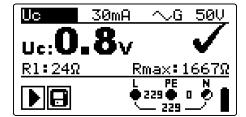
The contact voltage result relates to the rated nominal residual current of the RCD and is multiplied by an appropriate factor (depending on RCD type and type of test current). The 1.05 factor is applied to avoid negative tolerance of result. See table 5.1 for detailed contact voltage calculation factors.

RCD	type	Contact voltage Uc proportional to	Rated I _{ΔN}
AC	G	1.05×I _{∆N}	201/
AC	S	2×1.05×I _{∆N}	any
Α	G	1.4×1.05×I _{∆N}	> 20 m A
Α	S	$2\times1.4\times1.05\times I_{\Delta N}$	≥ 30 mA
Α	G	2×1.05×I _{ΔN}	< 30 mA
Α	S	2×2×1.05×I _{∆N}	> 30 IIIA

Table 5.1: Relationship between Uc and $I_{\Delta N}$

Loop resistance is indicative and calculated from Uc result (without additional proportional factors) according to: $R_L = \frac{U_C}{I_{con}}$.





UK version

Figure 5.3: Example of contact voltage measurement results

Displayed results:

Uc...... Contact voltage.

RI...... Fault loop resistance.

Rmax.. Maximum earth fault loop resistance value according to BS 7671.

5.1.2 Trip-out time (RCDt)

Trip-out time measurement verifies the sensitivity of the RCD at different residual currents.

Trip-out time measurement procedure

- Select the RCD function using the function selector switch.
- □ Set sub-function **RCDt**.
- □ Set test **parameters** (if necessary).
- □ **Connect** test cable to the top of the instrument.
- □ **Connect** test leads to the to the item to be tested (see *figure 5.2*).
- Press the **TEST** key to perform the measurement.
- □ **Store** the result by pressing the MEM key (optional).

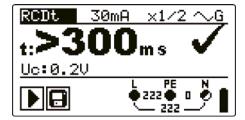


Figure 5.4: Example of trip-out time measurement results

Displayed results:

t Trip-out time,

Uc...... Contact voltage for rated $I_{\Lambda N}$.

5.1.3 Trip-out current (RCD I)

A continuously rising residual current is intended for testing the threshold sensitivity for RCD trip-out. The instrument increases the test current in small steps through appropriate range as follows:

RCD type	Slope range		Waveform
KCD type	Start value	End value	wavelonin
AC	$0.2 \times I_{\Delta N}$	$1.1 \times I_{\Delta N}$	Sine
A ($I_{\Delta N} \ge 30 \text{ mA}$)	$0.2 \times I_{\Delta N}$	1.5×I _{∆N}	Pulsed
A $(I_{\Delta N} = 10 \text{ mA})$	$0.2 \times I_{\Delta N}$	2.2×I _{∆N}	Fuiseu

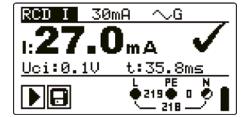
Maximum test current is I_{Δ} (trip-out current) or end value in case the RCD didn't trip-out.

Trip-out current measurement procedure

- Select the RCD function using the function selector switch.
- Set sub-function RCD I.
- □ Set test **parameters** (if necessary).
- □ **Connect** test cable to the top of the instrument.
- □ **Connect** test leads to the to the item to be tested (see *figure 5.2*).
- Press the **TEST** key to perform the measurement.
- □ **Store** the result by pressing the MEM key (optional).







After the RCD is turned on again

Figure 5.5: Trip-out current measurement result example

Displayed results:

I Trip-out current,

Uci...... Contact voltage at trip-out current I or end value in case the RCD didn't trip,

t Trip-out time.

5.1.4 RCD Autotest

RCD autotest function is intended to perform a complete RCD test (trip-out time at different residual currents, trip-out current and contact voltage) in one set of automatic tests, guided by the instrument.

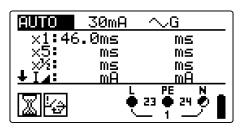
Additional key:

/ 5.651 43/	
HELP / DISPLAY	Toggles between top and bottom part of results field.

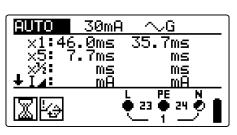
RCD autotest procedure

RC	RCD Autotest steps Notes		
	Select the RCD function using the function selector switch.		
	Set sub-function AUTO.		
	Set test parameters (if necessary).		
	Connect test cable to the top of the instrument.		
	Connect test leads to the to the item to be tested (see <i>figure</i>		
	5.2).		
	Press the TEST key to perform the test.	Start of test	
	Test with $I_{\Delta N}$, 0° (step 1).	RCD should trip-out	
	Re-activate RCD.		
	Test with $I_{\Delta N}$, 180° (step 2).	RCD should trip-out	
	Re-activate RCD.		
	Test with $5 \times I_{\Delta N}$, 0° (step 3).	RCD should trip-out	
	Re-activate RCD.		
	Test with $5 \times I_{\Delta N}$, 180° (step 4).	RCD should trip-out	
	Re-activate RCD.		
	Test with ½×I∆N, 0° (step 5).	RCD should not trip-out	
	Test with ½×I∆N, 180° (step 6).	RCD should not trip-out	
	Trip-out current test, 0° (step 7).	RCD should trip-out	
	Re-activate RCD.		
	Trip-out current test, 180° (step 8).	RCD should trip-out	
	Re-activate RCD.		
	Store the result by pressing the MEM key (optional).	End of test	

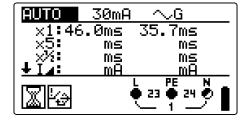
Result examples:



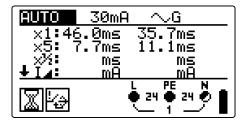
Step 1



Step 3



Step 2



Step 4

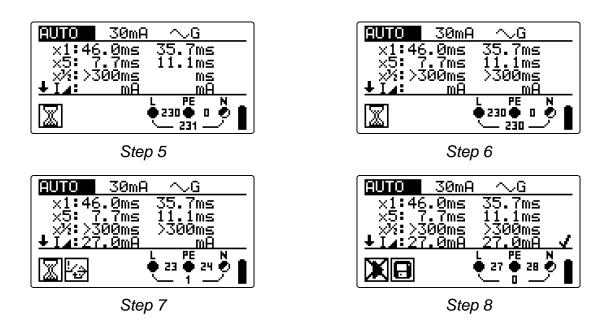


Figure 5.6: Individual steps in RCD autotest

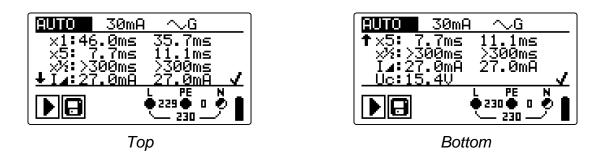


Figure 5.7: Two parts of result field in RCD autotest

```
Displayed results:

x1 ...... Step 1 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, I\Delta N, 0^{\circ}),

x1 ...... Step 2 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, I\Delta N, 180^{\circ}),

x5 ...... Step 3 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, 5 \times I\Delta N, 0^{\circ}),

x5 ...... Step 4 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, 5 \times I\Delta N, 180^{\circ}),

x½ ..... Step 5 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, ½×I\Delta N, 0^{\circ}),

x½ ..... Step 6 trip-out time (\mathbf{t} \stackrel{*}{\times} \mathbf{1}, ½×I\Delta N, 180^{\circ}),

I\Delta ...... Step 7 trip-out current (0^{\circ}),
```

Uc...... Contact voltage for rated I∆N.

Notes:

- □ The autotest sequence is immediately stopped if any incorrect condition is detected, e.g. excessive Uc or trip-out time out of bounds.
- Auto test is finished without x5 tests in case of testing the RCD type A with rated residual currents of $I\Delta n = 300$ mA, 500 mA, and 1000 mA. In this case auto test result passes if all other results pass, and indications for x5 are omitted.
- \Box Tests for sensitivity (I_A, steps 7 and 8) are omitted for selective type RCD.

5.2 Fault loop impedance and prospective fault current

Fault loop is a loop comprised by mains source, line wiring and PE return path to the mains source. The instrument measures the impedance of the loop and calculates the short circuit current and contact voltage. The measurement is covered by requirements of the EN 61557-3 standard.

See chapter *4.1 Function selection* for instructions on key functionality.

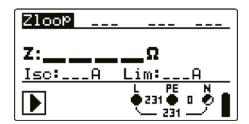


Figure 5.8: Fault loop impedance

Test parameters for fault loop impedance measurement

Test	Selection of fault loop impedance sub-function [Zloop, Zs rcd]
Fuse type	Selection of fuse type [, NV, gG, B, C, K, D]
Fuse I	Rated current of selected fuse
Fuse T	Maximum breaking time of selected fuse
Lim	Minimum short circuit current for selected fuse.

See Appendix A for reference fuse data.

Circuits for measurement of fault loop impedance

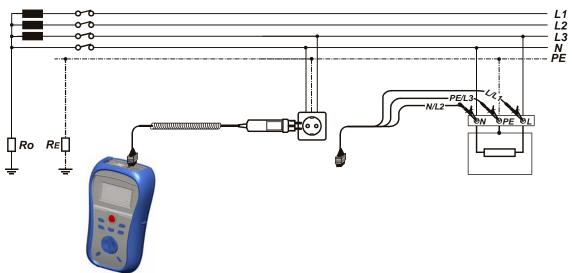
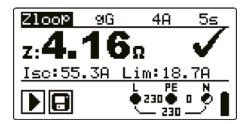
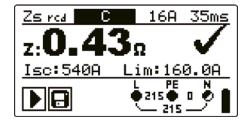


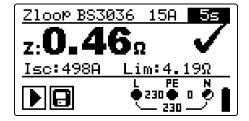
Figure 5.9: Connection of plug cable and universal test cable

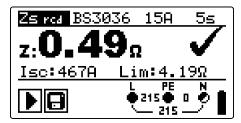
Fault loop impedance measurement procedure

- □ Select the **Z-LOOP** function using the function selector switch.
- □ Select test **parameters** (optional).
- □ **Connect** test cable to the top of the Smartec Z Line-Loop / RCD.
- □ **Connect** test leads to the to the item to be tested (see *figure 5.9*).
- □ Press the **TEST** key to perform the measurement.
- □ **Store** the result by pressing the MEM key (optional).









UK version

Figure 5.10: Examples of loop impedance measurement result

Displayed results:

Z.....Fault loop impedance,

Isc.....Prospective fault current,

LimLow limit prospective short-circuit current value or high limit fault loop impedance value for the UK version.

Prospective fault current I_{SC} is calculated from measured impedance as follows:

$$I_{SC} = \frac{Un \times k_{SC}}{Z}$$

where:

Un Nominal U_{L-PE} voltage (see table below),

ksc Correction factor for lsc (see chapter 4.2.6).

U _n Input voltage (L-PE)	
115 V	$(100 \text{ V} \le U_{L-PE} < 160 \text{ V})$
230 V	$(160 \text{ V} \le \text{U}_{\text{L-PE}} \le 264 \text{ V})$

Notes:

- □ High fluctuations of mains voltage can influence the measurement results (the noise sign is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.
- □ This measurement will trip-out the RCD in RCD-protected electrical installation if test Zloop is selected.
- □ Select Zs rcd to prevent trip-out of RCD in RCD protected installation.

5.3 Line impedance and prospective short-circuit current

Line impedance is measured in loop comprising of mains voltage source and line wiring. It is covered by requirements of the EN 61557-3 standard.

See chapter *4.1 Function selection* for instructions on key functionality.

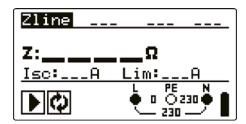


Figure 5.11: Line impedance

Test parameters for line impedance measurement

FUSE type	Selection of fuse type [, NV, gG, B, C, K, D]
FUSE I	Rated current of selected fuse
FUSE T	Maximum breaking time of selected fuse
Lim	Minimum short circuit current for selected fuse.

See Appendix A for reference fuse data.

Connections for measurement of line impedance

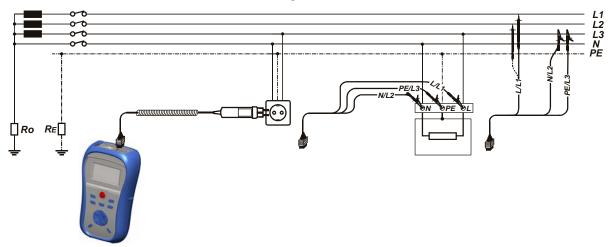
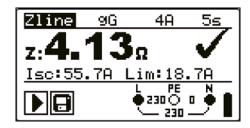


Figure 5.12: Phase-neutral or phase-phase line impedance measurement – connection of plug commander and universal test cable

Line impedance measurement procedure

- Select the Z-LINE function using the function selector switch.
- Select test parameters (optional).
- □ **Connect** test cable to the top of the instrument.
- □ **Connect** test leads to the to the item to be tested (see *figure 5.12*).
- Press the **TEST** key to perform the measurement.
- □ **Store** the result by pressing the MEM key (optional).



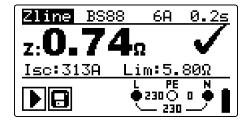
z:**0.28**_Ω

Iso:1.43kALim:320.0A

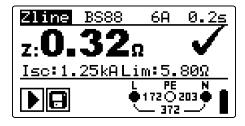
PE N

1720 203

Line to neutral



Line to line



UK version

Figure 5.13: Examples of line impedance measurement result

Displayed results:

Z....Line impedance,

Isc.....Prospective short-circuit current,

LimLow limit prospective short-circuit current value or high limit line impedance value for the UK version.

Prospective short circuit current is calculated as follows:

$$I_{SC} = \frac{Un \times k_{SC}}{Z}$$

where:

Un Nominal L-N or L1-L2 voltage (see table below),

ksc Correction factor for lsc (see chapter 4.2.6).

	Input voltage range (L-N or L1-L2)
115 V	$(100 \text{ V} \le U_{L-N} < 160 \text{ V})$
230 V	$(160 \text{ V} \le U_{L-N} \le 264 \text{ V})$
400 V	$(264 \text{ V} < U_{L-N} \le 440 \text{ V})$

Note:

□ High fluctuations of mains voltage can influence the measurement results (the noise sign is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.

5.4 Voltage, frequency and phase sequence

Voltage and frequency measurement is always active in the terminal voltage monitor. In the special **voltage trms** menu the measured voltage, frequency and information about detected three-phase connection can be stored. Phase sequence measurement conforms to the EN 61557-7 standard.

See chapter *4.1 Function selection* for instructions on key functionality.

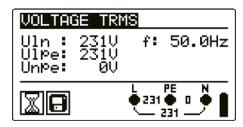


Figure 5.14: Voltage in single phase system

Test parameters for voltage measurement

There are no parameters to set.

Connections for voltage measurement

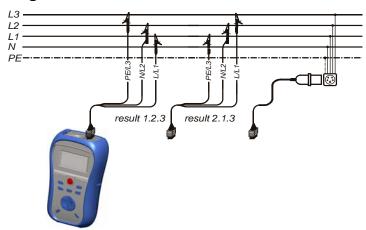


Figure 5.15: Connection of universal test cable and optional adapter in three-phase system

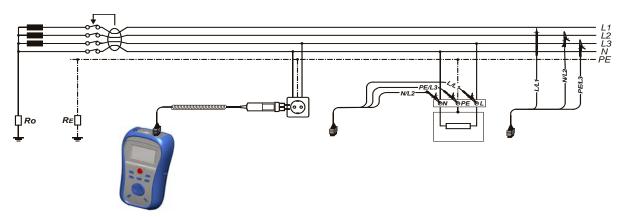
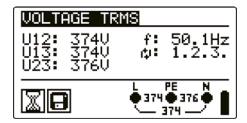


Figure 5.16: Connection of plug commander and universal test cable in single-phase system

Voltage measurement procedure

- Select the VOLTAGE TRMS function using the function selector switch.
- □ **Connect** test cable to the top of the instrument.
- □ **Connect** test leads to the to the item to be tested (see *figures 5.15* and *5.16*).
- □ **Store** current measurement result by pressing the MEM key (optional).

Measurement runs immediately after selection of **VOLTAGE TRMS** function.



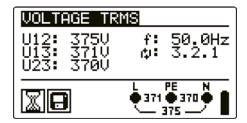


Figure 5.17: Examples of voltage measurement in three-phase system

Displayed results for **single phase** system:

Uln......Voltage between phase and neutral conductors, Ulpe......Voltage between phase and protective conductors, Unpe......Voltage between neutral and protective conductors, f.....frequency.

Displayed results for three-phase system:

U12......Voltage between phases L1 and L2,
U13.....Voltage between phases L1 and L3,
U23.....Voltage between phases L2 and L3,
1.2.3.....Correct connection – CW rotation sequence,
3.2.1....Invalid connection – CCW rotation sequence,

ffrequency.

5.5 PE test terminal

It can happen that a dangerous voltage is applied to the PE wire or other accessible metal parts. This is a very dangerous situation since the PE wire and MPEs are considered to be earthed. An often reason for this fault is incorrect wiring (see examples below).

When touching the **TEST** key in all functions that require mains supply the user automatically performs this test.

Examples for application of PE test terminal

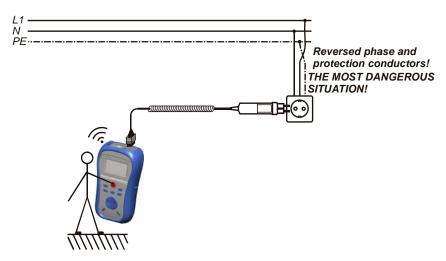


Figure 5.18: Reversed L and PE conductors (application of plug commander)

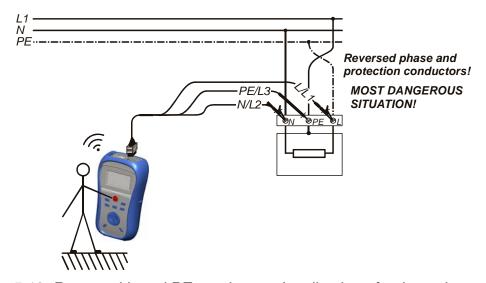


Figure 5.19: Reversed L and PE conductors (application of universal test cable)

PE terminal test procedure

- Connect test cable to the top of the instrument.
- □ **Connect** test leads to the to the item to be tested (see *figures 5.18* and *5.19*).
- □ Touch PE test probe (the **TEST** key) for at least one second.
- □ If PE terminal is connected to phase voltage the warning message is displayed, instrument buzzer is activated, and further measurements are disabled in Z-LOOP and RCD functions.

Warning:

□ If dangerous voltage is detected on the tested PE terminal, immediately stop all measurements, find and remove the fault!

Notes:

- □ In the SETTINGS and VOLTAGE TRMS menus the PE terminal is not tested.
- □ PE test terminal does not operate in case the operator's body is completely insulated from floor or walls!

6 Data handling

6.1 Memory organization

Measurement results together with all relevant parameters can be stored in the instrument's memory.

6.2 Data structure

The instrument's memory place is divided into 3 levels each containing 199 locations. The number of measurements that can be stored into one location is not limited.

The **data structure field** describes the identity of the measurement (which object, block, fuse) and where can be accessed.

In the **measurement field** there is information about type and number of measurements that belong to the selected structure element (object and block and fuse).

This organization helps to handle with data in a simple and effective manner.

The main advantages of this system are:

- □ Test results can be organized and grouped in a structured manner that reflects the structure of typical electrical installations.
- Simple browsing through structures and results.
- □ Test reports can be created with no or little modifications after downloading results to a PC.

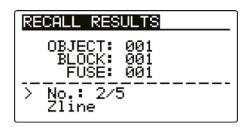


Figure 6.1: Data structure and measurement fields

Data structure field

RECALL R		Memory operation menu					
OBJECT: 0 BLOCK: 0 FUSE: 0	01 01 01	Data structure field					
OBJECT: 0		Root level in the structure:					
BLOCK: Ø		Sub-level (level 2) in the structure: □ BLOCK: 2 nd level location name. □ 001: No. of selected system.					
FUSE: 0		Sub-level (level 3) in the structure: □ FUSE: 3 rd level location name. □ 001: No. of selected element.					

Measurement field

Zline	Type of stored measurement in the selected location.					
No.: 2/5	No. of selected test result / No. of all stored test results in selected location.					

6.3 Storing test results

After the completion of a test the results and parameters are ready for storing (led icon is displayed in the information field). By pressing the **MEM** key, the user can store the results.

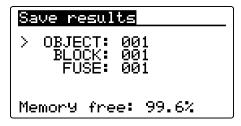


Figure 6.2: Save test menu

Memory free: 99.6% Memory available for storing results.

Keys in save test menu - data structure field:

TAB	Selects the location element (Object / Block / Fuse)						
UP / DOWN	Selects number of selected location element (1 to 199)						
MEM	Saves test results to the selected location and returns to the measuring menu.						
Function selectors / TEST	Exits back to main function menu.						

Notes:

- □ The instrument offers to store the result to the last selected location by default.
- □ If the measurement is to be stored to the same location as the previous one just press the **MEM** key twice.

6.4 Recalling test results

Press the **MEM** key in a main function menu when there is no result available for storing or select **MEMORY** in the **SETTINGS** menu.

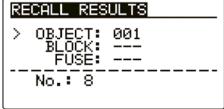


Figure 6.3: Recall menu - data structure field selected

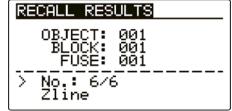


Figure 6.4: Recall menu - measurements field selected

Keys in recall memory menu (data structure field selected):

ТАВ	Selects the location element (Object / Block / Fuse). Enters measurements field.				
UP / DOWN	Selects number of selected location element (1 to 199).				
Function selectors / TEST	Exits back to main function menu.				

Keys in recall memory menu (measurements field selected):

UP / DOWN	Selects the stored measurement.
MEM	Displays measurement results.
Function selectors / TEST	Exits back to main function menu.

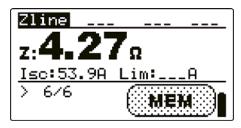


Figure 6.5: Example of recalled measurement result

Keys in recall memory menu (measurement results are displayed)

UP / DOWN	Displays measurement results stored in selected location				
MEM / TEST	Return to main MEM menu.				
Function selectors	Exit back to main function menu.				

6.5 Clearing stored data

6.5.1 Clearing complete memory content

Select **CLEAR ALL MEMORY** in **MEMORY** menu. A warning (see fig. 6.6) will be displayed.



Figure 6.6: Clear all memory

Keys in clear all memory menu

TEST	Confirms clearing of complete memory content.
Function selectors	Exits back to main function menu without changes.

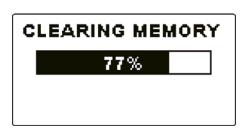


Figure 6.7: Clearing memory in progress

6.5.2 Clearing measurement(s) in selected location

Select **DELETE RESULTS** in **MEMORY** menu.

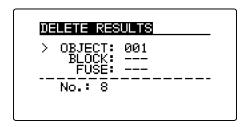


Figure 6.8: Clear measurements menu (data structure field selected)

Keys in delete results menu (data structure field selected):

ТАВ	Selects location element (Object / Block / Fuse). Enters measurements field.
UP / DOWN	Selects number of selected location element (1 to 199).
Function selectors / MEM	Exits back to main function menu.
TEST	Opens dialog for confirmation to clear result in selected location.

Keys in dialog for confirmation to clear results in selected location:

TEST	Deletes all results in selected location.				
MEM	Exits back to delete results menu without changes.				
Function selectors	Exits back to main function menu without changes.				

6.5.3 Clearing individual measurements

Select **DELETE RESULTS** in **MEMORY** menu.

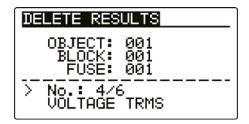


Figure 6.9: Clear measurements menu (data structure field selected)

Keys in delete results menu (measurements field selected)

TAB	Returns to data structure field.				
UP / DOWN	Selects measurement.				
TEST	Opens dialog for confirmation to clear selected measurement.				
Function selectors / MEM	Exits back to main function menu without changes.				

Keys in dialog for confirmation to clear selected result(s):

TEST	Deletes selected measurement result.						
MEM	Exits back to delete results menu – measurements field without changes.						
Function selectors	Exits back to main function menu without changes.						

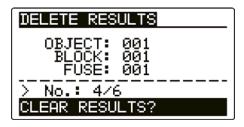


Figure 6.10: Dialog for confirmation

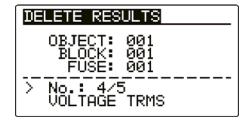


Figure 6.11: Display after measurement was cleared

6.6 Communication

Stored results can be transferred to a PC. A special communication program on the PC automatically identifies the instrument and enables data transfer between the instrument and the PC.

There are two communication interfaces available on the instrument: USB or RS 232.

The instrument automatically selects the communication mode according to detected interface. USB interface has priority.

PS/2 - RS 232 cable minimum connections: 1 to 2, 4 to 3, 3 to 5



Figure 6.12: Interface connection for data transfer over PC COM port

How to transfer stored data:

- □ RS 232 communication: connect a PC COM port to the instrument PS/2 connector using the PS/2 RS232 serial communication cable;
- □ USB communication selected: connect a PC USB port to the instrument USB connector using the USB interface cable.
- Switch on the PC and the instrument.
- Run the Eurolink program.
- □ The PC and the instrument will automatically recognize each other.
- The instrument is prepared to download data to the PC.

The program *Eurolink* is a PC software running on Windows 95/98, Windows NT, Windows 2000, Windows XP, Windows Vista. Read the file README_EuroLink.txt on CD for instructions about installing and running the program.

Note:

USB drivers should be installed on PC before using the USB interface. Refer to USB installation instructions available on installation CD.

7 Maintenance

Unauthorized persons are not allowed to open the Smartec Z Line-Loop / RCD instrument. There are no user replaceable components inside the instrument, except the battery under rear cover.

7.1 Cleaning

No special maintenance is required for the housing. To clean the surface of the instrument use a soft cloth slightly moistened with soapy water or alcohol. Then leave the instrument to dry totally before use.

Warnings:

- Do not use liquids based on petrol or hydrocarbons!
- Do not spill cleaning liquid over the instrument!

7.2 Periodic calibration

It is essential that the test instrument is regularly calibrated in order that the technical specification listed in this manual is guaranteed. We recommend an annual calibration. Only an authorized technical person can do the calibration. Please contact your dealer for further information.

7.3 Service

For repairs under warranty, or at any other time, please contact your distributor.

8 Technical specifications

8.1 RCD testing

8.1.1 General data

Nominal residual current (A,AC) 10 mA, 30 mA, 100 mA, 300 mA, 500 mA,

1000 mA

Nominal residual current accuracy.... -0 / +0.1·I Δ ; I Δ = I Δ N, 2×I Δ N, 5×I Δ N

 $-0.1 \cdot I\Delta / +0$; $I\Delta = 0.5 \times I\Delta N$

AS / NZ selected: ± 5 %

Test current shape...... Sine-wave (AC), pulsed (A)

DC offset for pulsed test current 6 mA (typical)

RCD type G (non-delayed), S (time-delayed)

Test current starting polarity 0 ° or 180 °

Voltage range 50 V ÷ 264 V (45 Hz ÷ 65 Hz)

RCD test current selection (r.m.s. value calculated to 20ms) according to IEC 61009:

	I∆N ×	1/2	I∆N × 1		I∆N × 2		I∆N × 5		RCD I∆	
I∆N (mA)	AC	Α	AC	Α	AC	Α	AC	Α	AC	Α
10	5	3.5	10	20	20	40	50	100	✓	✓
30	15	10.5	30	42	60	84	150	212	✓	✓
100	50	35	100	141	200	282	500	707	✓	✓
300	150	105	300	424	600	848	1500	n.a.	✓	✓
500	250	175	500	707	1000	1410	2500	n.a.	✓	✓
1000	500	350	1000	1410	2000	n.a.	n.a.	n.a.	✓	✓

n.a..... not applicable

AC type sine wave test current

A type..... pulsed current

8.1.2 Contact voltage RCD-Uc

Measuring range according to EN61557 is 20.0 V \div 31.0V for limit contact voltage 25V Measuring range according to EN61557 is 20.0 V \div 62.0V for limit contact voltage 50V

Measuring range (V)	Resolution (V)	Accuracy
0.0 ÷ 19.9	0.1	(-0 % / +15 %) of reading ± 10 digits
20.0 ÷ 99.9	0.1	(-0 % / +15 %) of reading

The accuracy is valid if mains voltage is stabile during the measurement and PE terminal is free of interfering voltages.

Specified accuracy is valid for complete operating range.

8.1.3 Trip-out time

Complete measurement range corresponds to EN 61557 requirements.

Maximum measuring times set according to selected reference for RCD testing.

Measuring range (ms)	Resolution (ms)	Accuracy
0.0 ÷ 40.0	0.1	±1 ms
0.0 ÷ max. time *	0.1	±3 ms

^{*} For max. time see normative references in 4.2.6 – this specification applies to max. time >40 ms.

 $5 \times I_{\Delta N}$ is not available for $I_{\Delta N}$ =1000 mA (RCD type AC) or $I_{\Delta N} \ge 300$ mA (RCD type A).

 $2 \times I_{\Delta N}$ is not available for $I_{\Delta N}$ =1000 mA (RCD type A).

Specified accuracy is valid for complete operating range.

8.1.4 Trip-out current

Trip-out current

Complete measurement range corresponds to EN 61557 requirements.

Measuring range I _∆	Resolution I _∆	Accuracy
$0.2 \times I_{\Delta N} \div 1.1 \times I_{\Delta N}$ (AC type)		
$0.2 \times I_{\Delta N} \div 1.5 \times I_{\Delta N}$ (A type, $I_{\Delta N} \ge 30$ mA)	$0.05 \times I_{\Delta N}$	$\pm 0.1 \times I_{\Delta N}$
$0.2 \times I_{\Delta N} \div 2.2 \times I_{\Delta N}$ (A type, $I_{\Delta N}$ <30 mA)		

Trip-out time

Measuring range (ms)	Resolution (ms)	Accuracy
0 ÷ 300	1	±3 ms

Contact voltage

Measuring range (V)	Resolution (V)	Accuracy
0.0 ÷ 19.9	0.1	(-0 % / +15 %) of reading \pm 10 digits
20.0 ÷ 99.9	0.1	(-0 % / +15 %) of reading

The accuracy is valid if mains voltage is stabile during the measurement and PE terminal is free of interfering voltages.

Specified accuracy is valid for complete operating range.

8.2 Fault loop impedance and prospective fault current

8.2.1 No disconnecting device or FUSE selected

Fault loop impedance

Measuring range according to EN61557 is $0.25 \Omega \div 9.99 k\Omega$.

Measuring range (Ω)	Resolution (Ω)	Accuracy
$0.00 \div 9.99$	0.01	±/5 % of roading ± 5 digita)
10.0 ÷ 99.9	0.1	\pm (5 % of reading + 5 digits)
100 ÷ 999	1	10.0/ of roading
1.00k ÷ 9.99k	10	± 10 % of reading

Prospective fault current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
0.00 ÷ 9.99	0.01	
10.0 ÷ 99.9	0.1	Consider accuracy of fault
100 ÷ 999	1	loop resistance
1.00k ÷ 9.99k	10	measurement
10.0k ÷ 23.0k	100	

The accuracy is valid if mains voltage is stabile during the measurement.

Test current (at 230 V)...... 6.5 A (10 ms)

8.2.2 RCD selected

Fault loop impedance

Measuring range according to EN61557 is 0.46 $\Omega \div 9.99$ k Ω .

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 9.99	0.01	±/5 % of roading ± 10 digits)
10.0 ÷ 99.9	0.1	\pm (5 % of reading + 10 digits)
100 ÷ 999	1	100/ of roading
1.00k ÷ 9.99k	10	± 10 % of reading

Acccuracy may be impaired in case of heavy noise on mains voltage

Prospective fault current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
$0.00 \div 9.99$	0.01	
10.0 ÷ 99.9	0.1	Consider accuracy of fault
100 ÷ 999	1	loop resistance
1.00k ÷ 9.99k	10	measurement
10.0k ÷ 23.0k	100	

No trip out of RCD.

R, XL values are indicative.

8.3 Line impedance and prospective short-circuit current

Line impedance

Measuring range according to EN61557 is $0.25 \Omega \div 9.99 k\Omega$.

Measuring range (Ω)	Resolution (Ω)	Accuracy
$0.00 \div 9.99$	0.01	+/F % of roading + F digita)
10.0 ÷ 99.9	0.1	\pm (5 % of reading + 5 digits)
100 ÷ 999	1	+ 10 % of roading
1.00k ÷ 9.99k	10	± 10 % of reading

Prospective short-circuit current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
$0.00 \div 0.99$	0.01	
1.0 ÷ 99.9	0.1	Consider assurably of line
100 ÷ 999	1	Consider accuracy of line resistance measurement
1.00k ÷ 99.99k	10	lesistance measurement
100k ÷ 199k	1000	

Test current (at 230 V)...... 6.5 A (10 ms)

R, XL values are indicative.

8.4 Voltage, frequency, and phase rotation

8.4.1 Phase rotation

8.4.2 Voltage

Measuring range (V)	Resolution (V)	Accuracy
0 ÷ 550	1	\pm (2 % of reading + 2 digits)

Result type...... True r.m.s. (trms)
Nominal frequency range...... 0 Hz, 15 Hz ÷ 500 Hz

8.4.3 Frequency

Measuring range (Hz)	Resolution (Hz)	Accuracy
15.0 ÷ 499.9	0.1	\pm (0.2 % of reading + 1 digit)

Nominal voltage range 20 V ÷ 550 V

8.5 Online terminal voltage monitor

Measuring range (V)	Resolution (V)	Accuracy
0 ÷ 550	1	±(2 % of reading + 2 digits)

8.6 General data

Operation typical 20 h Charger socket input voltage 12 V ± 10 % Charger socket input current...... 400 mA max. Overvoltage category...... 600 V CAT III / 300 V CAT IV Plug commander overvoltage category 300 V CAT III Protection classification double insulation Pollution degree 2 Protection degree IP 40 Weightxx kg, without battery cells Reference conditions Reference temperature range 10 °C ÷ 30 °C Reference humidity range...... 40 %RH ÷ 70 %RH Operation conditions Working temperature range 0 °C ÷ 40 °C Maximum relative humidity 95 %RH (0 °C ÷ 40 °C), non-condensing Storage conditions Temperature range -10 °C \div +70 °C Maximum relative humidity 90 %RH (-10 °C ÷ +40 °C) 80 %RH (40 °C ÷ 60 °C)

Communication transfer speed

RS 232......115200 baud USB256000 baud

The error in operating conditions could be at most the error for reference conditions (specified in the manual for each function) +1 % of measured value + 1 digit, unless otherwise specified in the manual for particular function.

A Appendix A - Fuse table

A.1 Fuse table - IPSC

Fuse type NV

I use type IV						
Rated	Disconnection time [s]					
current	35m	0.1	0.2	0.4	5	
(A)		Min. prospect	ive short- circ	uit current (A)		
2	32.5	22.3	18.7	15.9	9.1	
4	65.6	46.4	38.8	31.9	18.7	
6	102.8	70	56.5	46.4	26.7	
10	165.8	115.3	96.5	80.7	46.4	
16	206.9	150.8	126.1	107.4	66.3	
20	276.8	204.2	170.8	145.5	86.7	
25	361.3	257.5	215.4	180.2	109.3	
35	618.1	453.2	374	308.7	169.5	
50	919.2	640	545	464.2	266.9	
63	1217.2	821.7	663.3	545	319.1	
80	1567.2	1133.1	964.9	836.5	447.9	
100	2075.3	1429	1195.4	1018	585.4	
125	2826.3	2006	1708.3	1454.8	765.1	
160	3538.2	2485.1	2042.1	1678.1	947.9	
200	4555.5	3488.5	2970.8	2529.9	1354.5	
250	6032.4	4399.6	3615.3	2918.2	1590.6	
315	7766.8	6066.6	4985.1	4096.4	2272.9	
400	10577.7	7929.1	6632.9	5450.5	2766.1	
500	13619	10933.5	8825.4	7515.7	3952.7	
630	19619.3	14037.4	11534.9	9310.9	4985.1	
710	19712.3	17766.9	14341.3	11996.9	6423.2	
800	25260.3	20059.8	16192.1	13545.1	7252.1	
1000	34402.1	23555.5	19356.3	16192.1	9146.2	
1250	45555.1	36152.6	29182.1	24411.6	13070.1	

Fuse type gG

Rated	Disconnection time [s]					
current	35m	0.1	0.2	0.4	5	
(A)		Min. prospect	ive short- circu	uit current (A)		
2	32.5	22.3	18.7	15.9	9.1	
4	65.6	46.4	38.8	31.9	18.7	
6	102.8	70	56.5	46.4	26.7	
10	165.8	115.3	96.5	80.7	46.4	
13	193.1	144.8	117.9	100	56.2	
16	206.9	150.8	126.1	107.4	66.3	
20	276.8	204.2	170.8	145.5	86.7	
25	361.3	257.5	215.4	180.2	109.3	
32	539.1	361.5	307.9	271.7	159.1	
35	618.1	453.2	374	308.7	169.5	
40	694.2	464.2	381.4	319.1	190.1	
50	919.2	640	545	464.2	266.9	
63	1217.2	821.7	663.3	545	319.1	
80	1567.2	1133.1	964.9	836.5	447.9	
100	2075.3	1429	1195.4	1018	585.4	

Fuse type B

Rated	Disconnection time [s]				
current	35m	0.1	0.2	0.4	5
(A)		Min. prospect	ive short- circ	uit current (A)	
6	30	30	30	30	30
10	50	50	50	50	50
13	65	65	65	65	65
16	80	80	80	80	80
20	100	100	100	100	100
25	125	125	125	125	125
32	160	160	160	160	160
40	200	200	200	200	200
50	250	250	250	250	250
63	315	315	315	315	315

Fuse type C

ruse type C						
Rated	Disconnection time [s]					
current	35m	0.1	0.2	0.4	5	
(A)		Min. prospect	ive short- circ	uit current (A)		
0.5	5	5	5	5	2.7	
1	10	10	10	10	5.4	
1.6	16	16	16	16	8.6	
2	20	20	20	20	10.8	
4	40	40	40	40	21.6	
6	60	60	60	60	32.4	
10	100	100	100	100	54	
13	130	130	130	130	70.2	
16	160	160	160	160	86.4	
20	200	200	200	200	108	
25	250	250	250	250	135	
32	320	320	320	320	172.8	
40	400	400	400	400	216	
50	500	500	500	500	270	
63	630	630	630	630	340.2	

Fuse type K

ruse type K						
Rated	Disconnection time [s]					
current	35m	0.1	0.2	0.4		
(A)		Min. prospect	ive short- circ	uit current (A)		
0.5	7.5	7.5	7.5	7.5		
1	15	15	15	15		
1.6	24	24	24	24		
2	30	30	30	30		
4	60	60	60	60		
6	90	90	90	90		
10	150	150	150	150		
13	195	195	195	195		
16	240	240	240	240		
20	300	300	300	300		
25	375	375	375	375		
32	480	480	480	480		

Fuse type D

, p						
Rated	Disconnection time [s]					
current	35m	0.1	0.2	0.4	5	
(A)		Min. prospect	ive short- circ	uit current (A)		
0.5	10	10	10	10	2.7	
1	20	20	20	20	5.4	
1.6	32	32	32	32	8.6	
2	40	40	40	40	10.8	
4	80	80	80	80	21.6	
6	120	120	120	120	32.4	
10	200	200	200	200	54	
13	260	260	260	260	70.2	
16	320	320	320	320	86.4	
20	400	400	400	400	108	
25	500	500	500	500	135	
32	640	640	640	640	172.8	

A.2 Fuse table - impedances (UK)

Fuse type B

Fuse type C

1 400 1/100							
Rated	Disco	nnection tin	ne [s]	Rated	Disconnection time [s]		ne [s]
current		0.4	5	current		0.4	5
(A)	Max. lo	op impeda	nce (Ω)	(A)	Max. lo	op impeda	nce (Ω)
3		12,264	12,264				
6		6,136	6,136	6		3,064	3,064
10		3,68	3,68	10		1,84	1,84
16		2,296	2,296	16		1,152	1,152
20		1,84	1,84	20		0,92	0,92
25		1,472	1,472	25		0,736	0,736
32		1,152	1,152	32		0,576	0,576
40		0,92	0,92	40		0,456	0,456
50		0,736	0,736	50		0,368	0,368
63		0,584	0,584	63		0,288	0,288
80		0,456	0,456	80		0,232	0,232
100		0,368	0,368	100		0,184	0,184
125		0,296	0,296	125		0,144	0,144

Fuse type D

Fuse type BS 1361

Rated	Disco	nnection tin	ne [s]	Rated	Disconnection time [s]		ne [s]
current		0.4	5	current		0.4	5
(A)	Max. lo	op impeda	nce (Ω)	(A)	Max. lo	op impeda	nce (Ω)
6		1,536	1,536	5		8,36	13,12
10		0,92	0,92	15		2,624	4
16		0,576	0,576	20		1,36	2,24
20		0,456	0,456	30		0,92	1,472
25		0,368	0,368	45			0,768
32		0,288	0,288	60			0,56
40		0,232	0,232	80			0,4
50		0,184	0,184	100			0,288
63		0,144	0,144				
80		0,112	0,112				
100		0,088	0,088				
125		0,072	0,072	<u> </u>			

Fuse type BS 88

Fuse type BS 1362

1 400 1/20 20 00				. acc type			
Rated	Disco	Disconnection time [s]		Rated	Disconnection time [s]		ne [s]
current		0.4	5	current		0.4	5
(A)	Max. lo	op impeda	nce (Ω)	(A)	Max. lo	op impeda	nce (Ω)
6		6,816	10,8	3		13,12	18,56
10		4,088	5,936	13		1,936	3,064
16		2,16	3,344				
20		1,416	2,328	Fuse type	BS 3036		
25		1,152	1,84	Rated	Disco	nnection tir	ne [s]
32		0,832	1,472	current		0.4	5
40			1,08	(A)	Max. lo	op impeda	nce (Ω)
50			0,832	5		7,664	14,16
63			0,656	15		2,04	4,28
80			0,456	20		1,416	3,064
100			0,336	30		0,872	2,112
125			0,264	45			1,272
160			0,2	60			0,896
200			0,152	100			0,424

All impedances are scaled with factor 0.8.

B Appendix B - Accessories for specific measurements

The table below presents standard and optional accessories required for specific measurement. The accessories marked as optional may also be standard ones in some sets. Please see attached list of standard accessories for your set or contact your distributor for further information.

Function	Suitable accessories (Optional with ordering code A)
Line impedance	 Universal test cable
	□ Plug commander (A 1272)
	 Mains measuring cable
	□ Tip commander (A 1270)
	□ Three-phase adapter (A 1111)
Fault loop impedance	 Universal test cable
	□ Plug commander (A 1272)
	 Mains measuring cable
	□ Tip commander (A 1270)
	□ Three-phase adapter (A 1111)
RCD testing	 Universal test cable
	□ Plug commander (A 1272)
	 Mains measuring cable
	□ Three-phase adapter (A 1111)
Phase sequence	 Universal test cable
	□ Three-phase cable (A 1110)
	□ Three-phase adapter (A 1111)
Voltage, frequency	 Universal test cable
	□ Plug commander (A 1272)
	 Mains measuring cable
	□ Tip commander (A 1272)



Appendix B